

Physics

Physics Research Publications

Purdue University

Year 2004

Electron-phonon renormalization of
electronic band gaps of semiconductors:
Isotopically enriched silicon

S. Tsoi*	H. Alawadhi†	X. Lu‡
J. W. Ager**	C. Y. Liao††	H. Riemann‡‡
E. E. Haller§	S. Rodriguez¶	A. K. Ramdas

*

†

‡

**

††

‡‡

§

¶

||

This paper is posted at Purdue e-Pubs.

http://docs.lib.purdue.edu/physics_articles/483

Electron-phonon renormalization of electronic band gaps of semiconductors: Isotopically enriched silicon

S. Tsoi,¹ H. Alawadhi,² X. Lu,¹ J. W. Ager III,¹ C. Y. Liao,^{3,4} H. Riemann,⁵ E. E. Haller,^{3,4} S. Rodriguez,¹ and A. K. Ramdas¹

¹*Department of Physics, Purdue University, West Lafayette, Indiana 47907, USA*

²*Department of Basic Sciences, University of Sharjah, United Arab Emirates*

³*Lawrence Berkeley National Laboratory, Berkeley, California 94720, USA*

⁴*Department of Materials Science and Engineering, University of California at Berkeley, Berkeley, California 94720, USA*

⁵*IKZ, Berlin, Germany*

(Received 25 June 2004; published 3 November 2004)

Photoluminescence and wavelength-modulated transmission spectra displaying phonon-assisted indirect excitonic transitions in isotopically enriched ²⁸Si, ²⁹Si, ³⁰Si, as well as in natural Si, have yielded the isotopic mass (M) dependence of the indirect excitonic gap (E_{gx}) and the relevant phonon frequencies. Interpreting these measurements on the basis of a phenomenological theory for $(\partial E_{gx}/\partial M)$, we deduce $E_{gx}(M=\infty) = (1213.8 \pm 1.2)$ meV, the purely electronic value in the absence of electron-phonon interaction and volume changes associated with anharmonicity.

DOI: 10.1103/PhysRevB.70.193201

PACS number(s): 78.55.Ap, 63.20.Kr, 78.40.Fy

The electronic band structure of the tetrahedrally coordinated elemental group IV and the compound III-V and II-VI semiconductors have been experimentally delineated and theoretically calculated with exceptional completeness.¹ Until recently, the experimental determinations of the band gaps of these semiconductors were made on specimens whose isotopic composition reflected the elemental natural abundance. The situation in this regard changed dramatically with access to monoisotopic Ge in the late 1980s,² making possible the growth of large, isotopically engineered, single crystals. Isotopically controlled ¹²C_{1-x}¹³C_x single crystals of diamond have been grown over the entire composition range.³ Only recently,⁴ a similar achievement has been repeated with Si and single crystal isotopically enriched ²⁸Si, ²⁹Si, and ³⁰Si as well as isotopic alloys with a controlled M , the average resultant atomic mass, have been grown.

The changes in the band gaps (E_G) of semiconductors as a function of the thermodynamic variables pressure (P) and temperature (T) have been a subject of comprehensive investigations since the early days of semiconductor physics.⁵ With the advent of isotopically controlled specimens, their dependence on the average atomic mass can now be experimentally addressed. The variation of E_G as a function of M is expressed as⁶

$$\left(\frac{\partial E_G}{\partial M}\right)_{T,P} = \left(\frac{\partial E_G}{\partial M}\right)_{T,V} + \frac{D}{V} \left(\frac{\partial V}{\partial M}\right)_{T,P}. \quad (1)$$

Here, $D = -B(\partial E_G/\partial P)_{T,M}$ is the deformation potential for hydrostatic stress and the band gap in question; and B , the bulk modulus. The first term on the right-hand side of Eq. (1) reflects the variation of E_G with M , at given temperature and volume, due to electron-phonon interaction with contributions linear and quadratic in atomic displacements $u_n(\mathbf{q}, j)$, the former taken in second order perturbation (Fan terms⁷) and the latter in first order (Debye-Waller terms⁸); \mathbf{n} denotes the position of an atom, \mathbf{q} the wave vector of a phonon of branch j . The resultant variation in E_G is proportional to ther-

mal averages $\langle u_n^2(\mathbf{q}, j) \rangle$, which equal $(\hbar/M\omega_{\mathbf{q}j})(\bar{n}_{\mathbf{q}j} + \frac{1}{2})$, $\bar{n}_{\mathbf{q}j}$ being the Bose-Einstein occupation number. The use of the average mass is implicit in the virtual crystal approximation in the lattice dynamics of crystals with random isotopic disorder. At $T=0$ K, $\langle u_n^2(\mathbf{q}, j) \rangle = (\hbar/2M\omega_{\mathbf{q}j})$, the zero-point contribution. Thus, both the Fan and the Debye-Waller contributions to the *change* in E_G are proportional to $M^{-1/2}$ under the assumption that the phonon frequencies scale as the inverse square root of the average mass. However, at high temperatures $\langle u_n^2(\mathbf{q}, j) \rangle \approx (k_B T/M\omega_{\mathbf{q}j}^2)$ becomes independent of M and the isotopic effects should progressively become less important with increasing temperature. The second term in Eq. (1) results from the change in volume arising from the difference in average atomic mass. Hu *et al.*⁹ have shown recently that, at $T=0$ K,

$$\frac{1}{V} \left(\frac{\partial V}{\partial M}\right)_T = -\frac{\sqrt{6}B'\hbar}{a^{5/2}B^{1/2}M^{3/2}}, \quad (2)$$

where a is the lattice parameter defined by the cubic unit cell of Si and $B' = (\partial B/\partial P)_T$, the third order bulk modulus. Note, the *change* in E_G due to volume as a function of M , like that due to electron-phonon interaction, is proportional to $M^{-1/2}$.

In this paper we report on the phonon-assisted indirect transitions in nominally monoisotopic single crystals of ²⁸Si, ²⁹Si, and ³⁰Si as well as in Si with natural isotopic abundance (see Table I) observed in photoluminescence (PL) and wavelength-modulated transmission (WMT).

As is well known, the indirect transitions between the Γ_8^+ zone center valence band maximum and the Δ_1 conduction band minima along $\langle 100 \rangle$ of Si, observed in PL and absorption, occur with the emission or absorption of wave-vector-preserving optical and acoustic phonons having \mathbf{q} 's equal to that of Δ_1 ; at low temperatures, the indirect transitions are assisted by *phonon emission*. Thus, their signatures in PL occur at $E_{gx} - \hbar\omega_{\mathbf{q},j}$, where E_{gx} is the excitonic band gap and j corresponds to transverse acoustic (TA), longitudinal acoustic (LA), longitudinal optical (LO), and transverse

TABLE I. Isotopic composition and average masses of isotopically enriched Si samples.

	% ^{28}Si	% ^{29}Si	% ^{30}Si	M
Sample ^{28}Si	99.92	0.075	0.005	27.98
Sample $^{\text{Nat}}\text{Si}$	92.23	4.67	3.1	28.09
Sample ^{29}Si	4.3	91.37	4.3	28.98
Sample ^{30}Si	4.29	7.46	88.25	29.81

optical (TO) phonons. In a similar fashion, the indirect thresholds in absorption, revealed as derivative signatures in, say, WMT, are expected at $E_{gx} + \hbar\omega_{qj}$. A combination of PL and WMT thus yields both E_{gx} and $\hbar\omega_{qj}$ as functions of M .⁶

The PL spectra of the monoisotopic and natural Si are displayed in Fig. 1(a) at $T=20$ K and in Fig. 1(b) for $T=9$ K. The luminescence was excited with 500 mW of all lines from an Ar^+ laser focused to a spot 200 μm in diameter. The peaks in the PL spectra at 20 K are ascribed to excitonic indirect transitions mediated by the emission of TA, LO, and TO phonons which provide the wave-vector $|\mathbf{k}|=0.85(2\pi/a)$ along $\langle 100 \rangle$, the positions of the Δ_1 conduction band minima. Note, the PL signature labeled FE(TO+LO) is attributed to free exciton annihilation in which the TO and LO phonon-assisted parts are not resolved. Hammond *et al.*^{10,11} have shown that these can be resolved with higher resolution at 2.1 K. Such studies¹⁰ showed that the ratio of the intensities of the LO and TO signatures decreases from 0.3 at 2.1 K and approaches 0.1 by 10 K. From the theoretical expression in Ref. 10 for the line shape, which

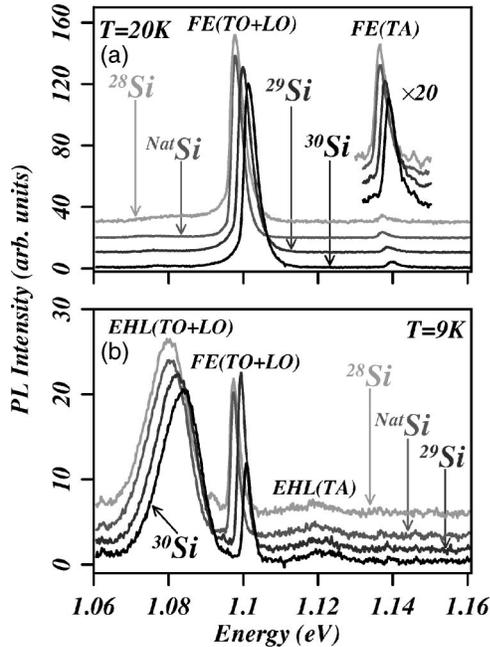


FIG. 1. Photoluminescence spectra of isotopically enriched and natural Si excited with an Ar^+ laser: (a) signatures of phonon-emission-assisted indirect excitonic transitions at 20 K and (b) at 9 K, showing additional electron-hole-liquid signatures.

TABLE II. Positions of peaks observed in PL and WMT.

	^{28}Si (meV)	$^{\text{Nat}}\text{Si}$ (meV)	^{29}Si (meV)	^{30}Si (meV)
PL				
FE(TA)	1135.83 ± 0.10	1135.98 ± 0.10	1137.21 ± 0.10	1138.28 ± 0.10
FE(TO)	1096.38 ± 0.10	1096.70 ± 0.10	1098.48 ± 0.10	1100.00 ± 0.10
EHL(TO)	1088.5 ± 0.3	1088.7 ± 0.3	1090.7 ± 0.3	1092.0 ± 0.3
WMT				
TA ($n=1$)	1173.05 ± 0.05	1173.15 ± 0.05	1173.80 ± 0.05	1174.39 ± 0.05
LO ($n=1$)	1210.61 ± 0.05	1210.67 ± 0.05	1210.68 ± 0.05	1210.74 ± 0.05
LO ($n=2$)	1221.17 ± 0.10	1221.18 ± 0.10	1221.28 ± 0.10	1221.39 ± 0.10
TO ($n=1$)	1212.67 ± 0.05	1212.72 ± 0.05	1212.72 ± 0.05	1212.74 ± 0.05
TO ($n=2$)	1223.24 ± 0.10	1223.23 ± 0.10	1223.29 ± 0.10	1223.34 ± 0.10

explicitly includes the sample temperature, it has been possible to deduce separately the positions of LO- and TO-assisted peaks. The TA-assisted excitonic transition, labeled FE(TA), is significantly weaker. The peak positions of the TA-, LO-, and TO-assisted excitonic transitions are listed in Table II. In the PL spectra recorded at 9 K [Fig. 1(b)], strong and broad peaks labeled EHL(TO+LO) appear at energies lower than those of FE(TO+LO); they correspond to TO- and LO-assisted recombination radiation from an electron-hole plasma, the electron-hole liquid.¹² The feature labeled EHL(TA) is similarly the TA-assisted recombination radiation from EHL. The high energy thresholds for EHL(TO) are given in Table II.

The WMT spectra shown in Fig. 2 display the derivative signatures at $[E_{gx}(n) + \hbar\omega_q]$ for the TA-, LO-, and TO-assisted creation of indirect excitons in their $n=1$, i.e., ground, and $n=2$, i.e., the first excited, states^{13,14} for the various isotopically enriched ^{28}Si , ^{29}Si , and ^{30}Si as well as for $^{\text{Nat}}\text{Si}$. The energies of these peaks are included in Table II.

Experiments on PL performed in the range 9 K to 20 K showed that the peak positions remained unchanged within experimental error (± 0.1 meV); similarly, for WMT, the peak positions did not change in going from 5 K to 20 K within ± 0.05 meV. In view of this, it is justifiable to attribute the isotope related shifts entirely to effects related to zero-point vibrations.

In Fig. 3 we present the E_{gx} , TO, LO, and TA energies as functions of M , deduced from the peak positions in Table II. The least squares fit follows $E_{gx}^\infty + CM^{-1/2}$ for the excitonic band gap E_{gx} , E_{gx}^∞ being (1213.8 ± 1.2) meV, the value for $M=\infty$. A linear fit can be made over the small range of masses with a slope $(\partial E_{gx}/\partial M)$ of 1.01 meV/amu. The phonon energies essentially obey $C'M^{-1/2}$. The apparent mass independence of the TO-assisted $n=1, 2$ excitons in Fig. 2 is accidental in that $C \approx -C'_{\text{TO}}$ as can be seen from a comparison of Figs. 3(a) and 3(c). The experiments also in-

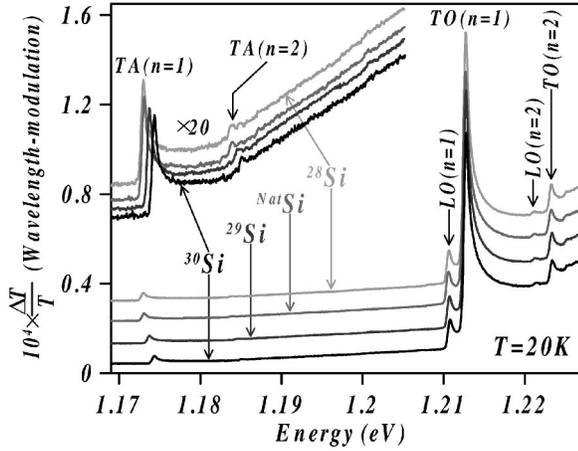


FIG. 2. Signatures of phonon-emission-assisted indirect excitonic transitions in isotopically enriched Si and ^{Nat}Si observed in wavelength-modulated transmission.

dicating that the separation of the $n=2$ and $n=1$ excitons is isotope mass independent. Thus, the excitonic binding energy appears to be independent of M within experimental errors.

In Table III we display in the third column the total change in the indirect excitonic energy per atomic mass unit $(\partial E_{gx}/\partial M)_{T,P}$, which has emerged from the present data for Si and compare it with those measured for diamond¹⁵ and Ge.⁶ In the fourth column we show the contribution from the isotope related change in the atomic volume, $(D/V)(\partial V/\partial M)_{T,P}$, calculated using (i) the measured values of the lattice parameter as a function of M and (ii) Eq. (2) expressed in terms of macroscopic parameters. The contribution from the electron-phonon interaction $(\partial E_{gx}/\partial M)_{T,V}$, shown in the fifth column, is then the difference between the values in columns III and IV according to Eq. (1). The last column gives the theoretical values in Zollner *et al.*¹⁸ and Lautenschlager *et al.*²² It is interesting to note that $(D/V)(\partial V/\partial M)_{T,P}$ deduced in these two ways agree very

TABLE III. Isotope mass renormalization of the indirect band gap in diamond, Si and Ge.

D (meV)	$(\frac{\partial E_{gx}}{\partial M})_{T,P}$	$\frac{D}{V}(\frac{\partial V}{\partial M})_{T,P}$ (meV/amu)	$(\frac{\partial E_{gx}}{\partial M})_{T,V}$	$(\frac{\partial E_{gx}}{\partial M})_{T,V}^{th}$
C	-2212 ^a	14.0 ^b	(i) 1 ^c	13.0
			(ii) 0.8 ^e	13.2
Si	1410 ^f	1.01 ^g	(i) -0.123 ^h	1.133
			(ii) -0.114 ^e	1.124
Ge	-3800 ^f	0.36 ^j	(i) 0.096 ^k	0.264
			(ii) 0.085 ^e	0.275

^aReference 16.

^bReference 15.

^cReference 17.

^dReference 18.

^eReference 19.

^fReference 20.

^gPresent results.

^hReference 21.

ⁱReference 22.

^jReference 6.

^kReference 9.

well. Equally noteworthy is the opposite signs of $(D/V)(\partial V/\partial M)_{T,P}$ for diamond and Ge on the one hand and Si on the other. The value for $(\partial E_{gx}/\partial M)_{T,V}$ deduced in this analysis for diamond and Ge are in reasonable agreement with the theoretical calculation of Zollner *et al.*¹⁸ and for Si with that in Lautenschlager *et al.*²²

Collins *et al.*,¹⁵ Davies *et al.*,²³ and Karaiskaj *et al.*²⁴ have addressed the phenomenon of isotopic mass dependence of the indirect gap in diamond, Ge and Si, respectively, on the basis of the energies of donor- or acceptor-bound excitons observed in PL. In order to deduce the mass dependence of the indirect gap they assume the binding energy of the bound exciton to be independent of M . Parks *et al.*⁶ have employed the combination of signatures in PL and modulated transmission and deduced both E_{gx} and the energies of the associated phonons; this procedure in Ge, as well as for Si in the present work, is free from the above assumption. It is gratifying to note that $(\partial E_{gx}/\partial M)_{T,P}$ in Refs. 6 and 23 (Ge) and Ref. 24 and the present work (Si) are in excellent agreement.

In Fig. 4 we display the WMT spectra where signatures labeled $\text{TO}_{\text{SO}}(n=1)$ and $\text{TA}+\text{O}(n=1)$ appear for ^{28}Si , ^{29}Si , and ^{30}Si . These features for ^{Nat}Si were observed by Nishino *et al.*¹⁴ who attributed the former to a TO-assisted creation of an indirect exciton associated with the spin-orbit split $\Gamma_7^+(p_{1/2})$ zone center valence band maximum and the Δ_1 conduction band minima. The basis for this interpretation is the magnitude of the spin-orbit splitting Δ_{SO} being 44.1 meV determined from the Lyman spectrum of boron acceptors in Si by Zwerdling *et al.*,²⁵ in exact coincidence with that from WMT.¹⁴ The feature labeled $\text{TA}+\text{O}(n=1)$ is due to the indirect excitonic transition from the Γ_8^+ valence band assisted by the simultaneous emission of TA and zone center optical phonon (O). The $\text{TO}_{\text{SO}}(n=1)$ signatures in ^{28}Si , ^{29}Si , and ^{30}Si coincide at (1.258 ± 0.002) eV, just as those of $\text{TO}(n=1)$ in Fig. 2 do at (1.21272 ± 0.00005) eV. From these observations we conclude that, within experimental errors, Δ_{SO} is independent of M , as expected from theory in the first approximation.

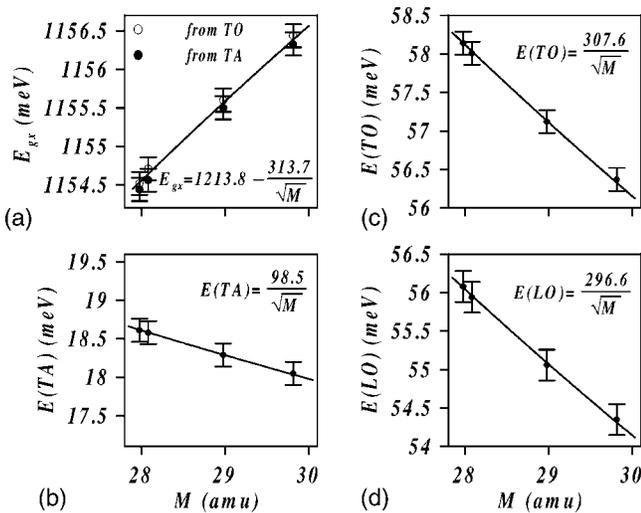


FIG. 3. The excitonic indirect band gap and the associated phonon energies as a function of M .

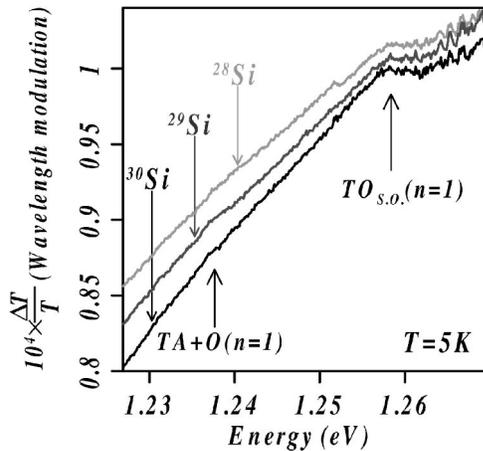


FIG. 4. The spin-orbit split indirect excitonic transitions in ^{28}Si , ^{29}Si , and ^{30}Si .

It is equally interesting to note that the work function for the formation of EHL, deduced from the line-shape analysis of its relatively broad signature in PL following Hammond *et al.*¹¹ and Lo,²⁶ is (8.0 ± 0.3) meV, independent of M .

The results obtained in the present investigation for Si, together with the earlier work for Ge and C, are examples of the unique scientific opportunities created by the access to isotopically controlled specimens of semiconductors. In Table III we have an instructive comparison of the change in their fundamental (indirect) energy gap (E_{gx}) as a function of M . $E_{gx}(M)$ for Si and Ge, analyzed in terms of Eq. (1), yield the purely “electronic” values for $M=\infty$, i.e., for the ideal semiconductor not influenced even by the zero-point motion. For the specific phonons involved in the indirect transitions, the $M^{-1/2}$ dependence is also more sharply delineated in comparison with those deduced from two-phonon infrared and Raman spectroscopies. The order of magnitude larger value for $(\partial E_{gx}/\partial M)_{T,P}$ for diamond in comparison to those of Si and Ge underscores the dramatic effect of the significantly larger zero-point motion in diamond.

The work at Purdue and UCB received support from the National Science Foundation Grant No. DMR0102699 and Grant No. DMR0109844, respectively. In addition, the U. S. Department of Energy Contract No. DE-AC03-76SF00098 supported the work at LBNL.

¹M. L. Cohen and J. R. Chelikowski, *Electronic Structure and Optical Properties of Semiconductors* (Springer-Verlag, Heidelberg, 1988).

²See, E. E. Haller, *J. Appl. Phys.* **77**, 2857 (1995).

³T. R. Anthony and W. F. Banholzer, *Diamond Relat. Mater.* **1**, 717 (1992).

⁴K. Takyu, K. M. Itoh, K. Oka, N. Saito, and V. I. Ozogin, *Jpn. J. Appl. Phys., Part 2* **38**, L1493 (1999); A. D. Bulanov, G. G. Devyatych, A. V. Gusev, P. G. Sennikov, H.-J. Pohl, H. Riemann, H. Schilling, and P. Becker, *Cryst. Res. Technol.* **35**, 1023 (2000); T. Ruf, R. W. Henn, M. Asen-Palmer, E. Gmelin, M. Cardona, H.-J. Pohl, G. G. Devyatych, and P. G. Sennikov, *Solid State Commun.* **115**, 243 (2000); F. Widulle, T. Ruf, M. Konuma, I. Silier, M. Cardona, W. Kriegseis, and V. I. Ozogin, *ibid.* **118**, 1 (2001).

⁵H. Y. Fan, *Rep. Prog. Phys.* **19**, 107 (1956).

⁶C. Parks, A. K. Ramdas, S. Rodriguez, K. M. Itoh, and E. E. Haller, *Phys. Rev. B* **49**, 14244 (1994).

⁷H. Y. Fan, *Phys. Rev.* **82**, 900 (1951).

⁸E. Antončík, *Czech. J. Phys., Sect. A* **5**, 449 (1955).

⁹M. Y. Hu, H. Sinn, A. Alatas, W. Sturhahn, E. E. Alp, H.-C. Wille, Yu. V. Shvyd'ko, J. P. Sutter, J. Bandaru, E. E. Haller, V. I. Ozogin, S. Rodriguez, R. Colella, E. Kartheuser, and M. A. Villeret, *Phys. Rev. B* **67**, 113306 (2003).

¹⁰R. B. Hammond, D. L. Smith, and T. C. McGill, *Phys. Rev. Lett.* **35**, 1535 (1975).

¹¹R. B. Hammond, T. C. McGill, and J. W. Mayer, *Phys. Rev. B* **13**, 3566 (1976).

¹²For an excellent review, see J. P. Wolfe and C. D. Jeffries, in *Electron-hole Droplets in Semiconductors*, edited by C. D. Jeffries and L. V. Keldysh (North-Holland, Amsterdam, 1983), p. 431.

¹³K. L. Shaklee and R. E. Nahory, *Phys. Rev. Lett.* **24**, 942 (1970).

¹⁴T. Nishino, M. Takeda, and Y. Hamakawa, *Solid State Commun.* **12**, 1137 (1973); **14**, 627 (1974).

¹⁵A. T. Collins, S. C. Lawson, G. Davies, and H. Kanda, *Phys. Rev. Lett.* **65**, 891 (1990).

¹⁶P. J. Dean and P. A. Crowther, in *Radiative Recombination in Semiconductors*, edited by C. Benoit a la Guillaume (Dunod, Paris, 1965), p. 103.

¹⁷H. Holloway, K. C. Hass, M. A. Tamor, T. R. Anthony, and W. F. Banholzer, *Phys. Rev. B* **44**, 7123 (1991).

¹⁸S. Zollner, M. Cardona, and S. Gopalan, *Phys. Rev. B* **45**, 3376 (1992).

¹⁹Computed using Eq. (2) with parameters from Landolt-Börnstein, New Series, Group III: *Crystal and Solid State Physics*, edited by O. Madelung, M. Schulz, and H. Weiss (Springer-Verlag, Heidelberg, 1982), Vol. 17 a.

²⁰U. Schmid, N. E. Christensen, and M. Cardona, *Solid State Commun.* **75**, 39 (1990).

²¹H.-C. Wille, Yu. V. Shvyd'ko, E. Gerdau, M. Lerche, M. Lucht, H. D. Rüter, and J. Zegenhagen, *Phys. Rev. Lett.* **89**, 285901 (2002).

²²Calculated from Fig. 5 in P. Lautenschlager, P. B. Allen, and M. Cardona, *Phys. Rev. B* **31**, 2163 (1985). We thank M. Cardona for bringing this reference to our attention.

²³G. Davies, E. C. Lightowers, K. Itoh, W. L. Hansen, E. E. Haller, and V. Ozogin, *Semicond. Sci. Technol.* **7**, 1271 (1992).

²⁴D. Karaiskaj, M. L. W. Thewalt, T. Ruf, M. Cardona, and M. Konuma, *Solid State Commun.* **123**, 87 (2002).

²⁵S. Zwerdling, K. J. Button, B. Lax, and L. M. Roth, *Phys. Rev. Lett.* **4**, 173 (1960).

²⁶T. K. Lo, *Solid State Commun.* **15**, 1231 (1974).